

Search Notes

Application/Control No.

10/784,188

Examiner

John C. Hong

Applicant(s)/Patent under
Reexamination

MARUYAMA ET AL.

Art Unit

3726

SEARCHED

Class	Subclass	Date	Examiner
29	592	11/13/2005	<i>AW</i>
	426.3		
	426.1		
	705		
	403.1		
	403.2		
	403.3		
	428		
	429		
	430		
	700		
	703		
	705		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
29	426.3	11/13/2005	<i>AW</i>
	426.1		
	705		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	11/13/2005	<i>AW</i>